

IS61LV256

32K x 8 LOW VOLTAGE CMOS STATIC RAM

FEATURES

- High-speed access times:
 - 8, 10, 12, 15, 20 ns
- Automatic power-down when chip is deselected
- CMOS low power operation
 - 345 mW (max.) operating
 - 7 mW (max.) CMOS standby
- TTL compatible interface levels
- Single 3.3V power supply
- Fully static operation: no clock or refresh required
- Three-state outputs

DESCRIPTION

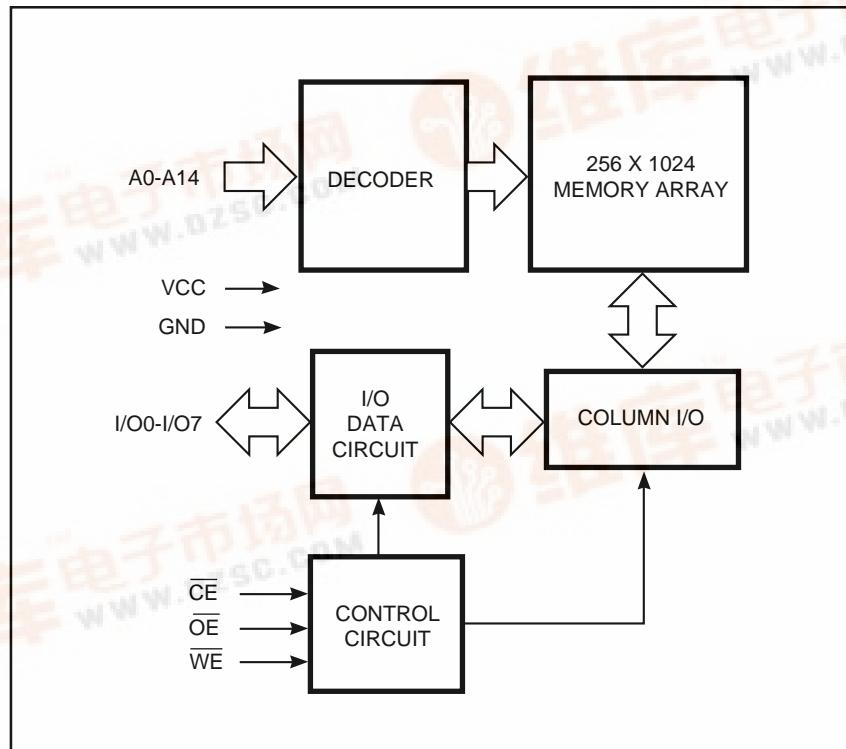
The *ICSI* IS61LV256 is a very high-speed, low power, 32,768-word by 8-bit static RAM. It is fabricated using *ICSI*'s high-performance CMOS technology. This highly reliable process coupled with innovative circuit design techniques, yields access times as fast as 8 ns maximum.

When \overline{CE} is HIGH (deselected), the device assumes a standby mode at which the power dissipation is reduced to 50 μ W (typical) with CMOS input levels.

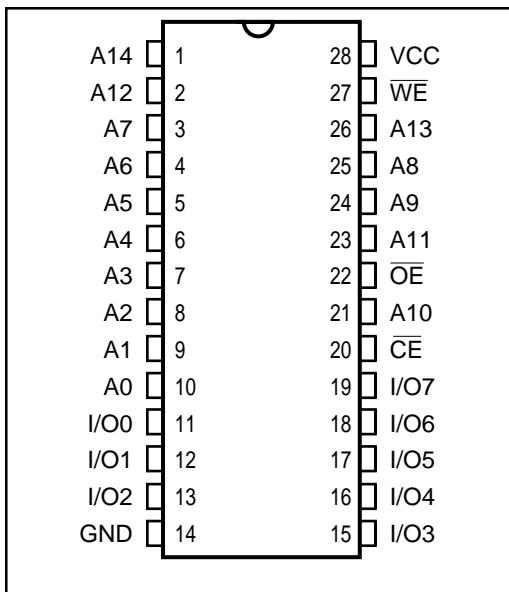
Easy memory expansion is provided by using an active LOW Chip Enable (\overline{CE}). The active LOW Write Enable (\overline{WE}) controls both writing and reading of the memory.

The IS61LV256 is available in the JEDEC standard 28-pin, 300mil SOJ and the 8*13.4mm TSOP-1 package.

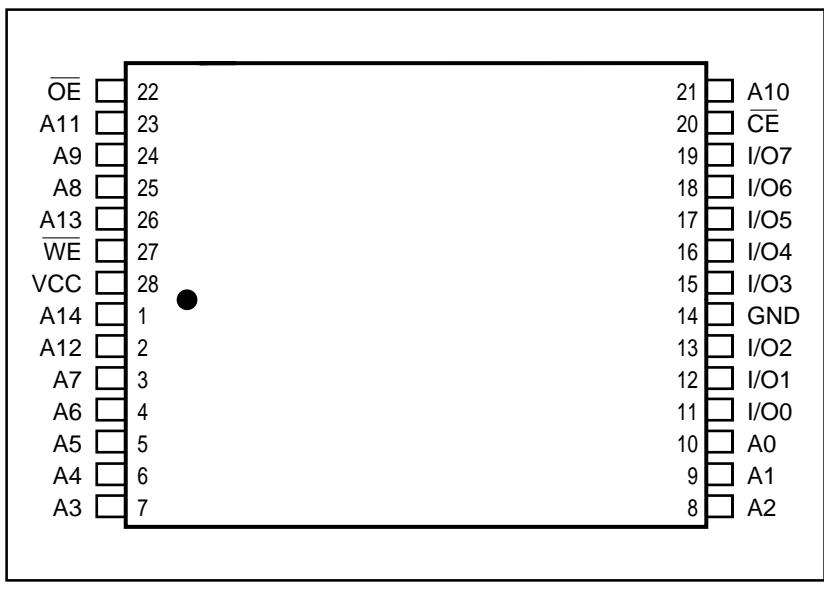
FUNCTIONAL BLOCK DIAGRAM



PIN CONFIGURATION 28-Pin SOJ



PIN CONFIGURATION 8x13.4mm TSOP-1



PIN DESCRIPTIONS

A0-A14	Address Inputs
CE	Chip Enable Input
OE	Output Enable Input
WE	Write Enable Input
I/O0-I/O7	Input/Output
Vcc	Power
GND	Ground

TRUTH TABLE

Mode	WE	CE	OE	I/O Operation	Vcc Current
Not Selected (Power-down)	X	H	X	High-Z	Isb1, Isb2
Output Disabled	H	L	H	High-Z	Icc
Read	H	L	L	DOUT	Icc
Write	L	L	X	DIN	Icc

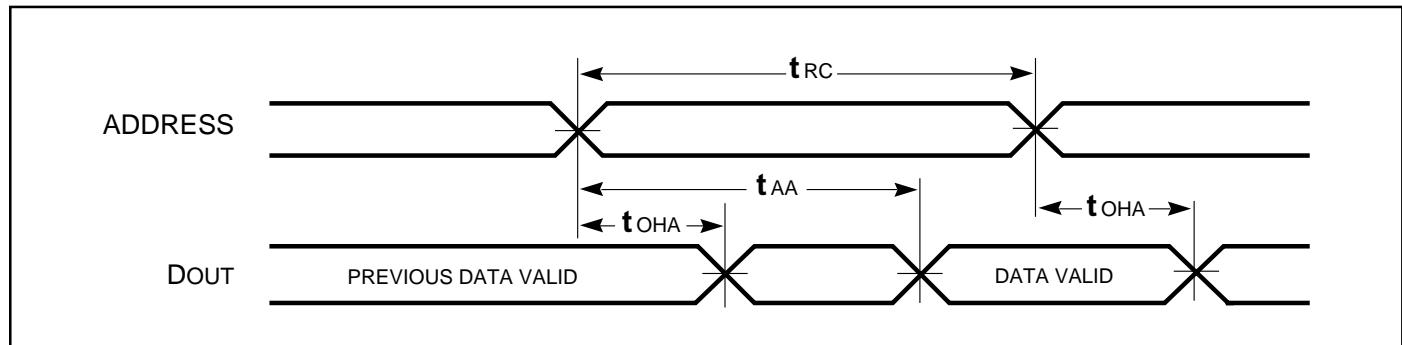
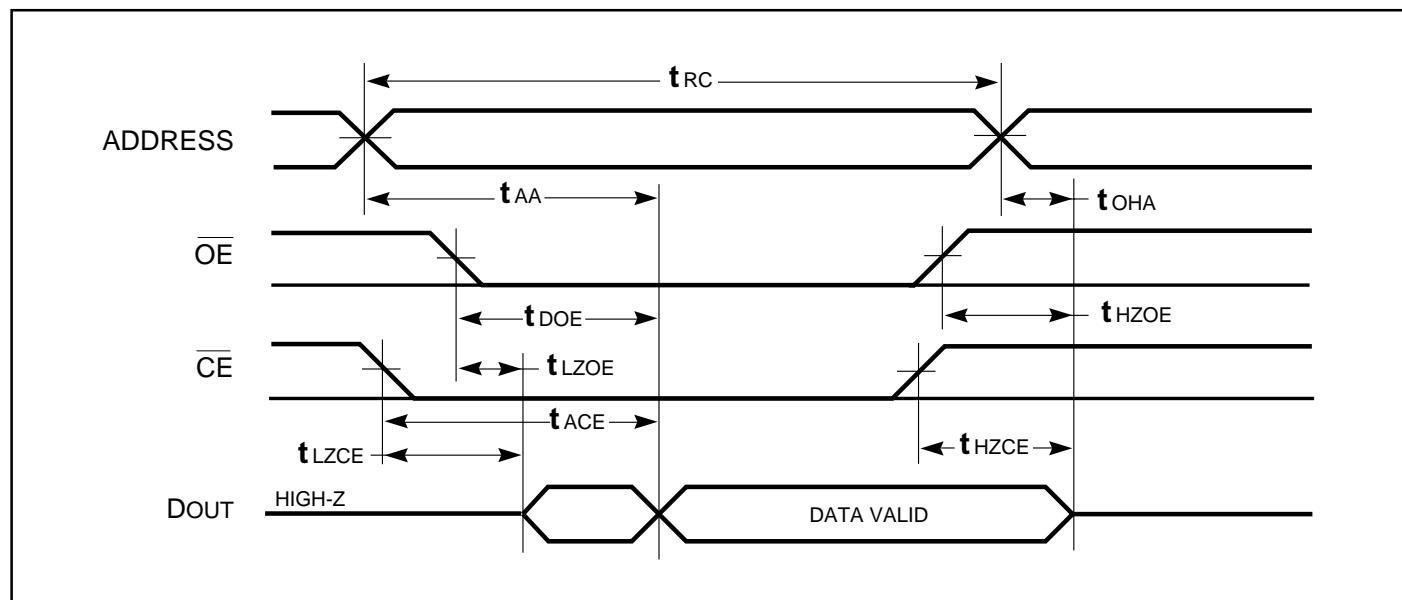
ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Parameter	Value	Unit
Vcc	Power Supply Voltage Relative to GND	-0.5 to +4.6	V
VTERM	Terminal Voltage with Respect to GND	-0.5 to +4.6	V
TBIAS	Temperature Under Bias	Com. Ind.	-10 to +85 °C -45 to +90
TSTG	Storage Temperature	-65 to +150	°C
Pd	Power Dissipation	1	W
Iout	DC Output Current	±20	mA

Notes:

1. Stress greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

AC WAVEFORMS

READ CYCLE NO. 1^(1,2)READ CYCLE NO. 2^(1,3)

Notes:

1. \overline{WE} is HIGH for a Read Cycle.
2. The device is continuously selected. \overline{OE} , \overline{CE} = V_{IL} .
3. Address is valid prior to or coincident with \overline{CE} LOW transitions.

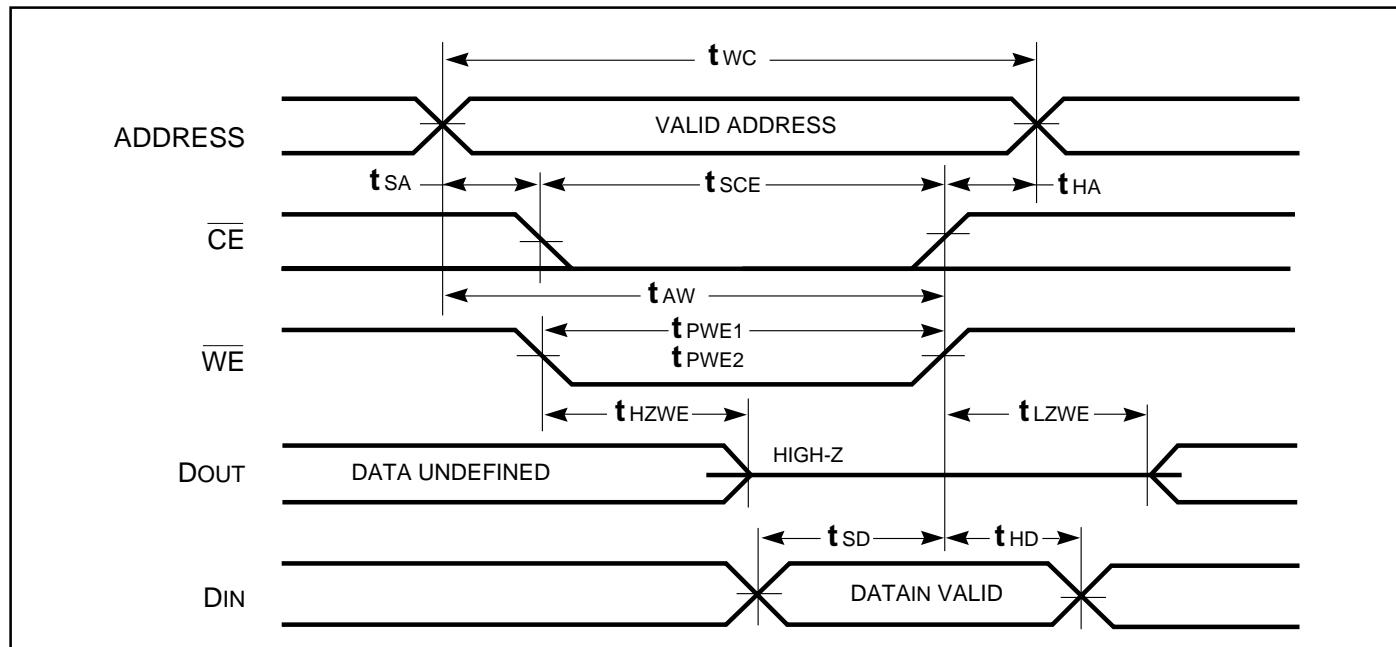
WRITE CYCLE SWITCHING CHARACTERISTICS^(1,2) (Over Operating Range)

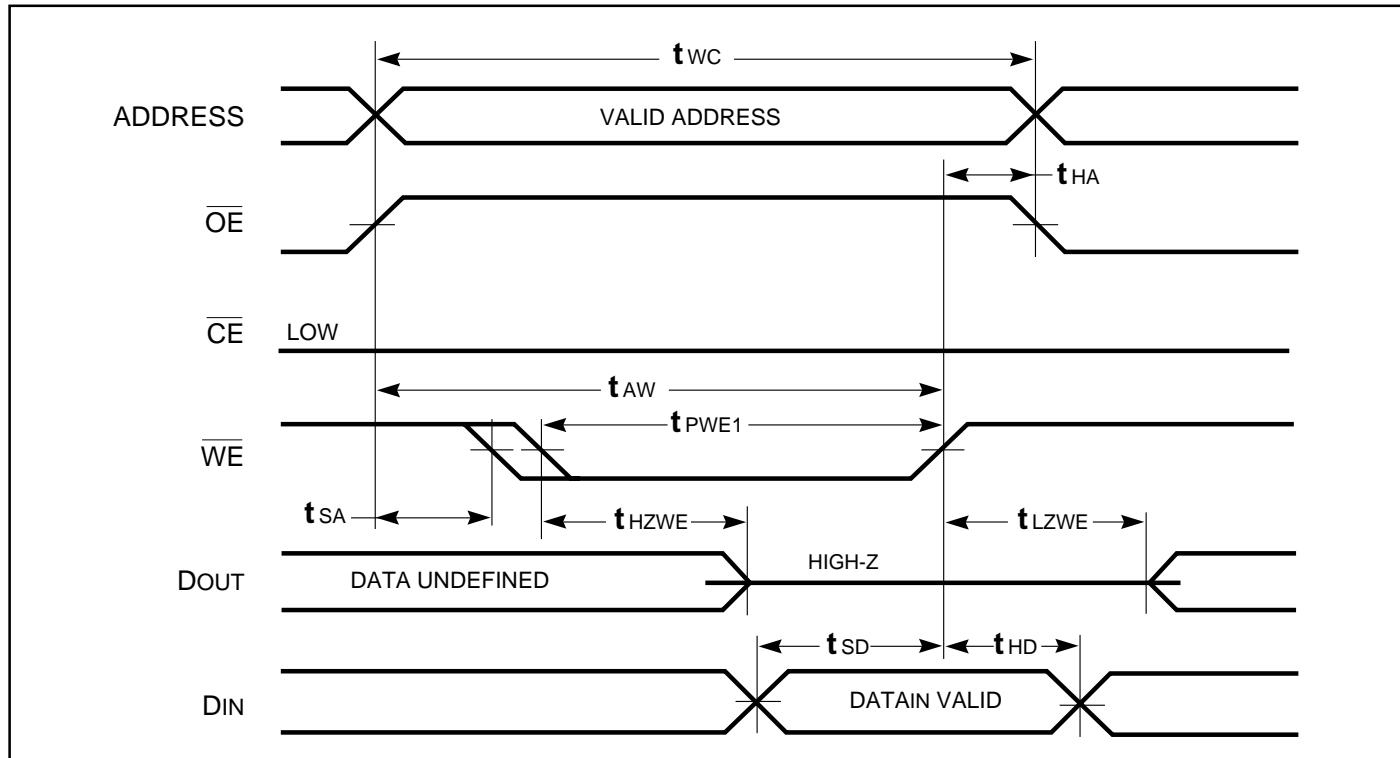
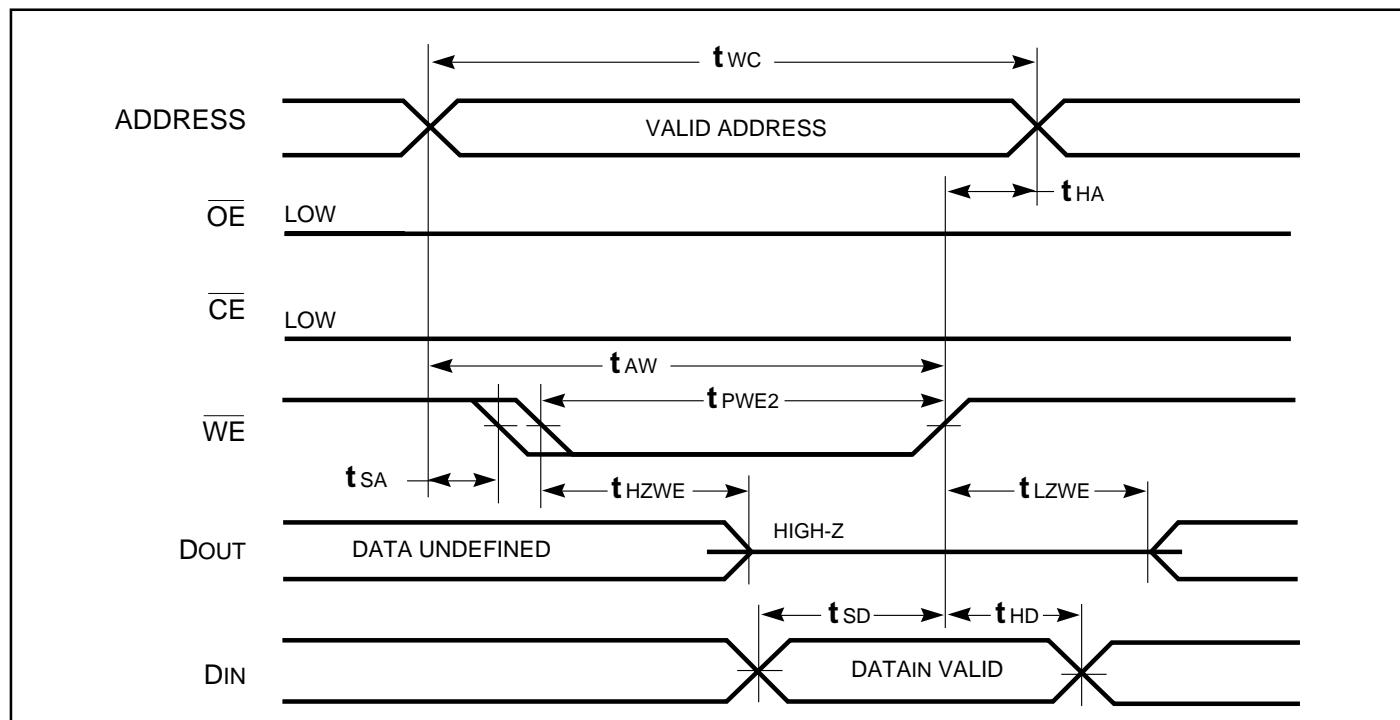
Symbol	Parameter	-8 ns		-10 ns		-12 ns		-15 ns		-20 ns		Unit
		Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t _{WC}	Write Cycle Time	8	—	10	—	12	—	15	—	20	—	ns
t _{SCE}	CE to Write End	7	—	8	—	8	—	10	—	12	—	ns
t _{AW}	Address Setup Time to Write End	7	—	8	—	8	—	10	—	12	—	ns
t _{HA}	Address Hold from Write End	0	—	0	—	0	—	0	—	0	—	ns
t _{SA}	Address Setup Time	0	—	0	—	0	—	0	—	0	—	ns
t _{PWE1}	WE Pulse Width(OE High)	7	—	10	—	12	—	15	—	20	—	ns
t _{PWE2}	WE Pulse Width(OE Low)	6.5	—	7	—	8	—	10	—	12	—	ns
t _{SD}	Data Setup to Write End	4.5	—	5	—	6	—	7	—	10	—	ns
t _{HD}	Data Hold from Write End	0	—	0	—	0	—	0	—	0	—	ns
t _{HZWE} ⁽³⁾	WE LOW to High-Z Output	—	3.5	—	4	—	6	—	7	—	7	ns
t _{LZWE} ⁽³⁾	WE HIGH to Low-Z Output	0	—	0	—	0	—	0	—	0	—	ns

Notes:

- Test conditions assume signal transition times of 3 ns or less, timing reference levels of 1.5V, input pulse levels of 0 to 3.0V and output loading specified in Figure 1.
- The internal write time is defined by the overlap of CE LOW and WE LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the Write.
- Tested with the load in Figure 2. Transition is measured ± 500 mV from steady-state voltage. Not 100% tested.

AC WAVEFORMS

WRITE CYCLE NO. 1 (CE Controlled, OE is HIGH or LOW)⁽¹⁾

WRITE CYCLE NO. 2 (\overline{WE} Controlled, \overline{OE} is HIGH During Write Cycle) ^(1,2)

 WRITE CYCLE NO. 3 (\overline{WE} Controlled, \overline{OE} is LOW During Write Cycle) ⁽¹⁾


Notes:

1. The internal write time is defined by the overlap of \overline{CE} LOW and \overline{WE} LOW. All signals must be in valid states to initiate a Write, but any one can go inactive to terminate the Write. The Data Input Setup and Hold timing are referenced to the rising or falling edge of the signal that terminates the Write.
2. I/O will assume the High-Z state if $\overline{OE} \geq V_{IH}$.

ORDERING INFORMATION

Commercial Range: 0°C to +70°C

Speed (ns)	Order Part No.	Package
8	IS61LV256-8T	8*13.4mm TSOP-1
	IS61LV256-8J	300mil SOJ
10	IS61LV256-10T	8*13.4mm TSOP-1
	IS61LV256-10J	300mil SOJ
12	IS61LV256-12T	8*13.4mm TSOP-1
	IS61LV256-12J	300mil SOJ
15	IS61LV256-15T	8*13.4mm TSOP-1
	IS61LV256-15J	300mil SOJ
20	IS61LV256-15T	8*13.4mm TSOP-1
	IS61LV256-20J	300mil SOJ

ORDERING INFORMATION

Industrial Range: -40°C to +85°C

Speed (ns)	Order Part No.	Package
8	IS61LV256-8TI	8*13.4mm TSOP-1
	IS61LV256-8JI	300mil SOJ
10	IS61LV256-10TI	8*13.4mm TSOP-1
	IS61LV256-10JI	300mil SOJ
12	IS61LV256-12TI	8*13.4mm TSOP-1
	IS61LV256-12JI	300mil SOJ
15	IS61LV256-15TI	8*13.4mm TSOP-1
	IS61LV256-15JI	300mil SOJ
20	IS61LV256-20TI	8*13.4mm TSOP-1
	IS61LV256-20JI	300mil SOJ

*Integrated Circuit Solution Inc.*

HEADQUARTER:

NO.2, TECHNOLOGY RD. V, SCIENCE-BASED INDUSTRIAL PARK,
HSIN-CHU, TAIWAN, R.O.C.

TEL: 886-3-5780333

Fax: 886-3-5783000

BRANCH OFFICE:

7F, NO. 106, SEC. 1, HSIN-TAI 5TH ROAD,
HSICHIH TAIPEI COUNTY, TAIWAN, R.O.C.

TEL: 886-2-26962140

FAX: 886-2-26962252

<http://www.icsi.com.tw>